



CMP SLURRY MEASUREMENT USING ACOUSTIC SPECTROSCOPY

The presence of a small population of large particles in chemical mechanical polishing (CMP) slurries is known to cause defects in the final products. Acoustic spectroscopy can sense the presence of a small sub-population of large particles in a concentrated dispersion of much smaller particles. The detection limit can be as low as a single one micron particle per 100,000 particles of 100 nm size. This is equivalent to a large particle content of 1 wt. % relative to the total solid content of the CMP slurry.

Introduction

Modern chemical polishing materials present a new challenge for measuring techniques for several reasons. The mean size of CMP materials is approximately 100 nm with few if any larger than 500 nm. Secondly, the range in the size of the particles may be greater than 1000:1 which also eliminates many classical techniques. Thirdly, CMP systems are typically shear sensitive. Shear caused by the polishing process itself or the delivery system may cause unpredictable assembly of the smaller particles into larger aggregates. However, these aggregates may be weakly formed and easily destroyed by subsequent sonication, high shear, or dilution. Therefore, any technique which requires dilution or other sample preparation steps could potentially destroy the very aggregates that one is attempting to quantify by measurement. To circumvent this possibility, we suggest that CMP systems be characterized as is, without any dilution or sample preparation.

Acoustic spectroscopy [1-3] provides an exciting alternative to more classical methods. The technique resolves all three issues mentioned above. It is known that acoustic spectroscopy is able to characterize particles as small as 10 nanometers [4] and as large as 10 microns, providing at least a 1000:1 range. Most importantly, the technique requires no dilution and is suitable for measuring slurries, as is, up to 45% by volume [5,6]. These unique features make acoustic spectroscopy very attractive for characterizing the particle size distribution (PSD) of CMP slurries.

However, there is one feature of acoustic spectroscopy which thus far has not been described sufficiently in the literature: namely the ability to characterize a bimodal PSD. Although Takeda et al [7] demonstrated that acoustic spectroscopy is able to characterize bimodal distributions of mixed alumina particles, the ultimate sensitivity in detecting one very small sub-population in combination with another dominant mode has not yet been investigated. Yet, it is just this feature, the ability to recognize a small sub-population, which is most critical for CMP studies. This paper addresses this important issue.

Unfortunately, there is no agreement in the literature as to the number of larger particles which might be allowed in a CMP slurry. We will assume for the moment that only 1 large particle of 1 micron size might be allowed per 100,000 small 100 nm particles. This target sensitivity corresponds to large particles amounting to 1% of the total weight of all particulates.

Of course, an acoustic spectrometer does not directly measure particle size. In fact, it measures an attenuation spectra and calculates the particle size assuming a certain model for describing the sound attenuation in terms of the physical properties of the system. It follows therefore that this target sub-population sensitivity needs to be translated into a corresponding precision and accuracy specification for the attenuation measurement. We will show that, from a theoretical standpoint, the required accuracy is roughly 0.01 dB/cm/MHz. The first set of experiments was performed with a single component system of silica Ludox-TM to confirm that the



DT-1201 acoustic spectrometer indeed meets this target requirement.

A second set of experiments was then made to test whether the attenuation spectra changed reproducibly when a small amount of the larger particles was added to a single component slurry of smaller particles. Two slurries were used for the small particles: Ludox-TM and Cabot SS25. Two silica Geltech samples with nominal sizes 0.5 and 1.5 micron were used as the model large particles. It was shown that the change in the attenuation spectra was statistically significant when the large particles amounted to at least 2 % of the total weight of all particulates. Expressed another way, the detection limit for this 12 wt % slurry corresponded to a sub-population which was only 0.24 wt % in terms of the total sample weight, or 0.24 g of large particles per 100 g of the slurry.

Experimental Technique

All measurements shown in this study were analyzed on the model DT-1200 system made by Dispersion Technology [8] and sold supported by HORIBA Instruments. A model dispersion with a known bimodal particle size distribution (PSD) was created by adding a small amount of larger particles to a stable slurry containing only small particles. Silica Ludox-TM (30 nm) and Cabot SS25 (63 nm) were used to represent typical CMP slurries. Two samples of Silica Geltech (0.5 and 1.5 micron) were used to model the offending aggregate particles. It is shown that the attenuation spectra measured with the DT-1200 has sufficient sensitivity that it can detect the larger particles at concentrations as low as 2% relative to the total solid content of the slurry (12 wt %). Moreover, the bimodal

PSD calculated from the attenuation spectra are consistent with the known composition of these mixed model dispersions. Importantly, a software error analysis can correctly select either a bimodal distribution or a lognormal representation of the test samples.

Materials

Four silica materials were used in this study. Two small sized particles were used, namely Silica Ludox-TM and Cabot SS25. Two larger sized particles were employed, namely Geltech 0.5 and Geltech 1.5. We assumed a density of 2.1 g/cm³ for all silica particles.

Slurries were prepared at 12 weight % for each material as follows:

The Silica Ludox-TM was supplied as a 50 wt % slurry which was diluted to 12 wt % with 0.01 M KCl solution resulting in a sample pH of 9.3.

The Geltech samples were supplied as a dry powder, which was dispersed in 0.01 M KCl solution and adjusted to pH 9.6 with KOH. The dispersion was repeatedly sonicated, stirred, and allowed to equilibrate for 5 hours before being measured.

The Cabot SS25 silica was diluted to 12 wt % with 0.01 M KCl.

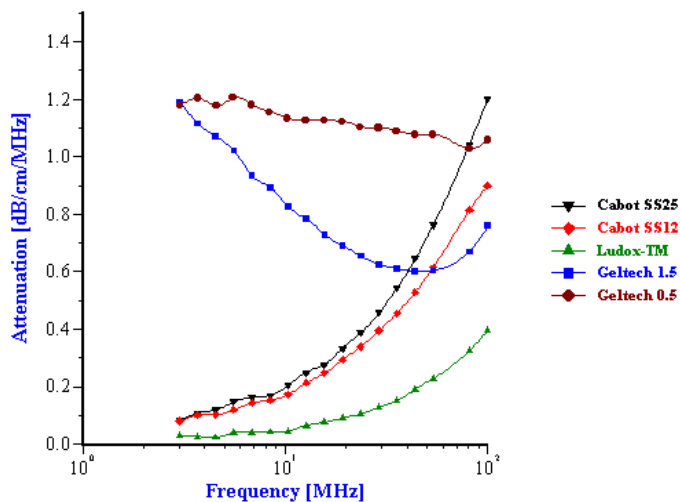
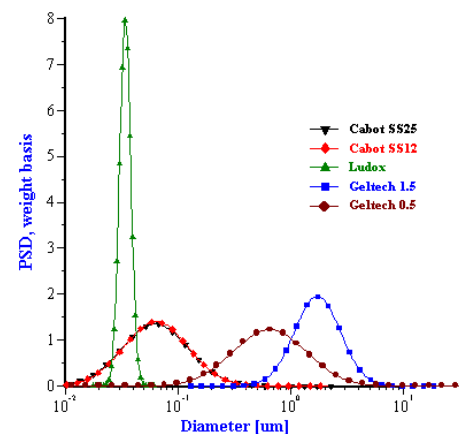
Table 1 presents particle size data provided by the manufacturer for each of these samples along with mean results as measured on the DT-1201.

**Table 1: Comparison of Manufacturer's particle size specification and measurement result from DT-1201 acoustic spectrometer for five materials**

	Manufacturer Size Specification	Acoustics Size Determination
Ludox-TM	22 nm (area basis)	30 nm (weight basis)
Geltech 0.5	0.5 micron	0.65 micron
Geltech 1.5	1.5 micron	1.72 micron
Cabot SS12	N/A	63 nm
Cabot SS25	N/A	62 nm

Results and Discussion

The attenuation spectra for all five single component silica slurries are shown in *Figure 1* and the corresponding particle size distributions for these same samples are shown in *Figure 2*. These tests allowed us to compare the particle size determined by acoustic spectroscopy for the five 12 wt % test slurries with independent data from the manufacturers. The values of the median size in each case are shown in Table 1. It is interesting to note that there is some difference between the acoustically measured data and that provided by the manufacturer. In large part this is related to differences in the characterization technique.

**Figure 1: Attenuation spectra for single component silica slurries****Figure 2: Corresponding particle size distributions**



Successful reproducibility and accuracy results then encouraged us to move to the next step which is a test of the ability to correctly determine bimodal PSD. We used Ludox-TM or CMP SS12 small particles as the major component of a slurry. The Geltech 0.5 or Geltech 1.5 was used as "large" and "larger" particles in the minor component of the mixed slurry. In each case the minor fraction was added to the Ludox-TM or the CMP SS12 systems in steps. Each addition increased the relative amount of the larger particles by 2%. The attenuation spectra were measured twice for each mixed system in order to demonstrate reproducibility.

Figures 3-6 give the results of these mixed system tests. It is seen that attenuation increases with increasing amounts of the "large" or "larger" particles. The increase in the attenuation with increasing doses of the Geltech content is in all cases significantly larger than reproducibility of the instrument. This demonstrates that the DT-1201 data contains significant information about the small amount of large particles. Figure 6 shows the calculated particle size distributions for the silica Cabot SS25 with various additions of Geltech 0.5.

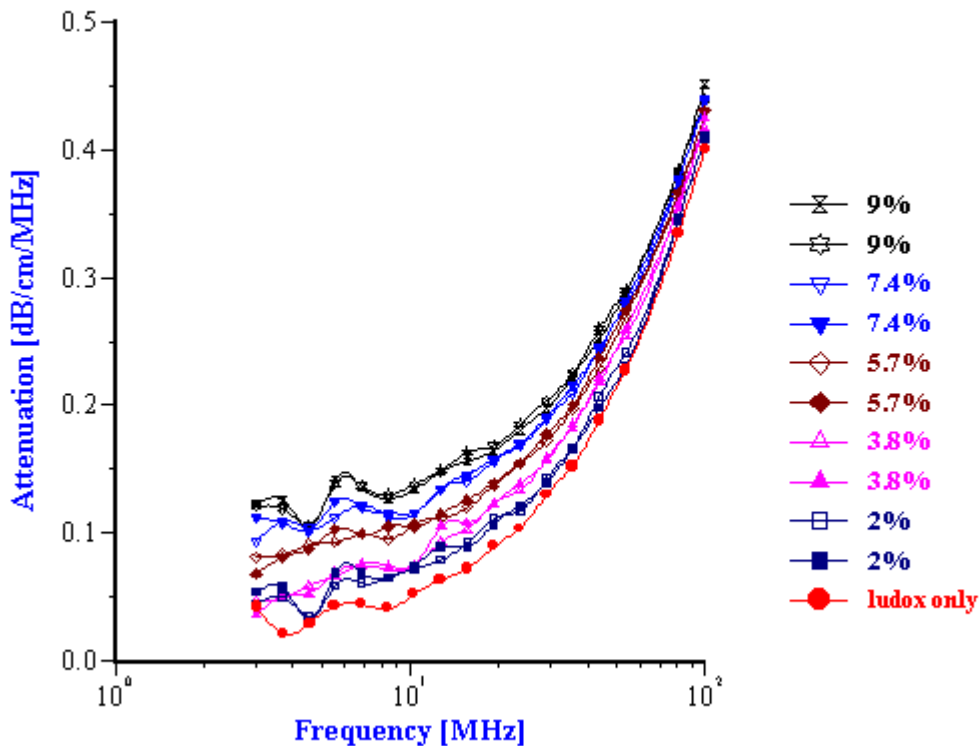


Figure 3: Silica Ludox-TM 50 with various additions of silica Geltech 0.5

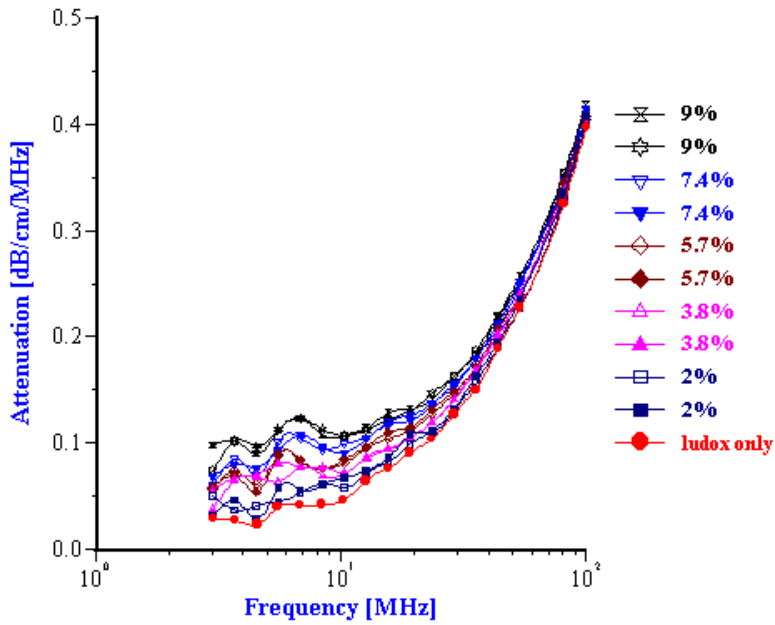


Figure 4: Silica Ludox-TM 50 with various additions of silica Geltech 1.5

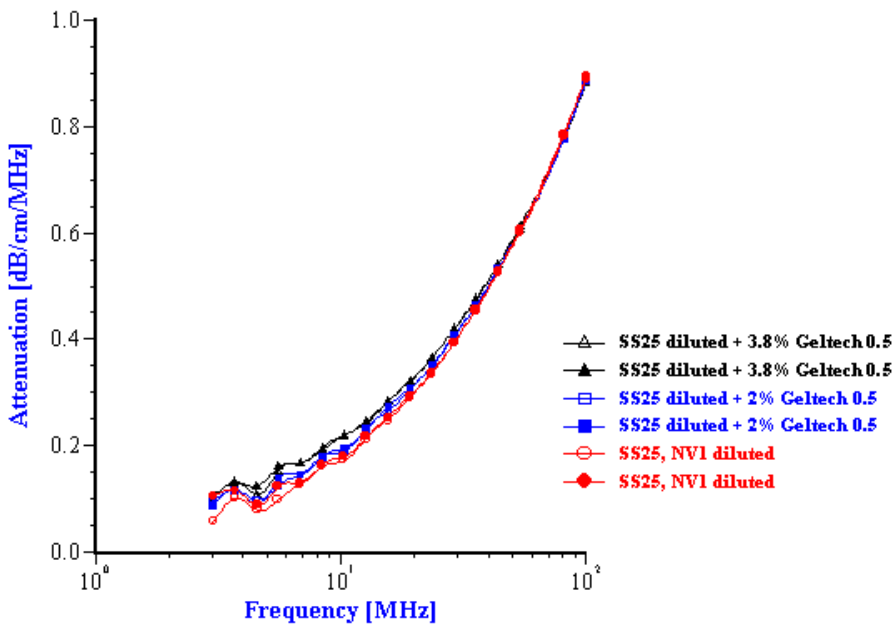
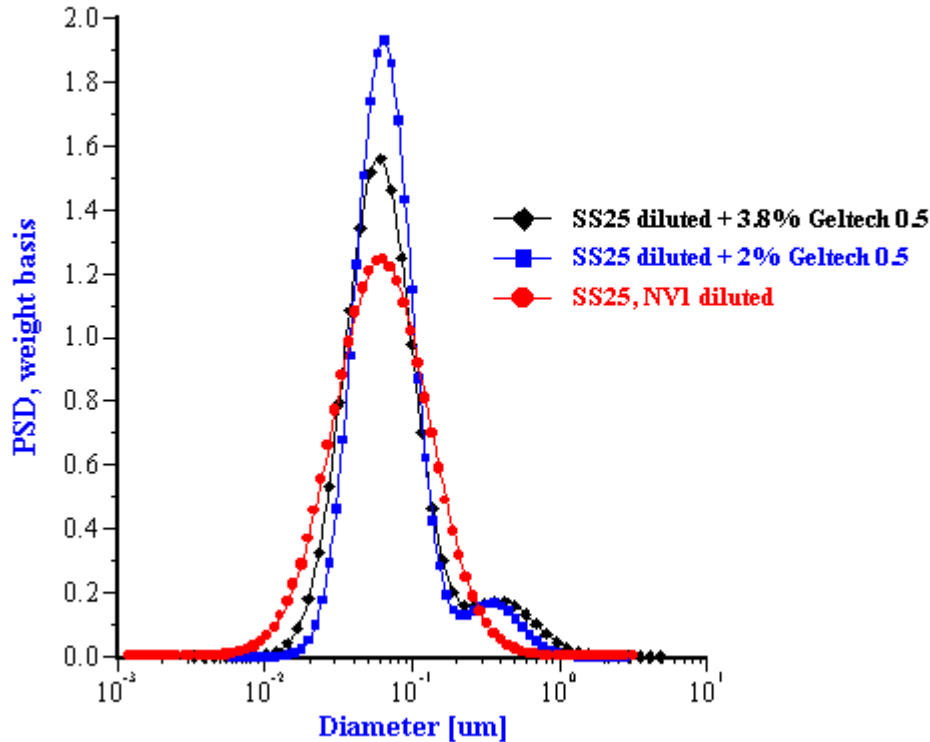


Figure 5: Silica Cabot SS25, diluted down to 12 wt %, with various additions of silica Geltech 0.5



10/18/98 13:40:24 Graph1

Figure 6: Particle size distributions of silica Cabot SS25, diluted down to 12 wt %, with various additions of silica Geltech 0.5

The final question is to determine whether the resultant PSD accurately calculates a correct bimodal distribution for these mixed material systems. *Table 2* gives an answer to this question. The DT-1201 always calculates a lognormal and a bimodal distribution which best fits the experimental data. These two PSD are best in the sense that the fitting error between the theoretical attenuation calculated for the best PSD and the experimental attenuation is minimized. These fitting errors are important criteria for deciding whether the lognormal or bimodal PSD is more appropriate for describing a particular sample. For instance, the PSD is judged to be bimodal only if the bimodal fit yields substantially smaller fitting error than a lognormal PSD. The values for the lognormal and bimodal fitting errors are given in the *Table 2*. It is seen that fitting error for the bimodal PSD is better than the lognormal for all of the mixed systems over the whole range concentration and for both the large and larger sized particles. According to the fitting errors, all PSD in the mixed Ludox-Geltech systems are bimodal, which of course is correct for these known mixed systems.

**Table 2: Compilation of result data from DT-1201 for various additions of Geltech 0.5 and 1.5**

Actual Geltech content, wt %	Calculated for Geltech 0.5				Calculated for Geltech 1.5			
	content (%)	larger size (μm)	lognormal fitting error (%)	bimodal fitting error (%)	content (%)	larger size (μm)	lognormal fitting error (%)	bimodal fitting error (%)
9	14	0.7	14.1	7.3	11	1.6	24.5	4.4
9	15	0.9	10.9	8.7	12	1.7	17.7	5.5
7.4	8	0.9	13.6	4.5	10	1.9	17.8	6
7.4	12	1	15.4	7.1	10	1.9	17.3	5.4
5.7	7	0.9	13.8	4.3	7	1.9	17.2	4.1
5.7	10	1.3	12.9	7.2	6	1.6	18.5	4.7
3.8	4	0.9	9.5	3.7	5	1.3	18.1	3.9
3.8	4	0.7	12	4.3	6	1.6	16.9	3.8
2	4	0.6	10.8	3.6	3	1.9	12.2	2.6
2	5	1.2	12.2	3.7	4	1.6	12.3	3.9

Conclusions

We assumed that characterization of CMP slurries requires the detection of 1 particle with 1 micron diameter per 100,000 small particles with diameter 100 nanometers. This is equivalent to large particles having a weight equal to 1% of the total particulates in the slurry.

Experimental reproducibility and accuracy tests show that the DT-1200 acoustic spectrometer meets the target detection requirement for characterizing small amounts of large particles in CMP slurries.

Attenuation spectra measured using the DT-1201 acoustic spectrometer reflects the presence of the added small amounts of large particles. Particle size distributions calculated from these attenuation spectra are bimodal according to the suggested PSD criterion. This criterion applies fitting errors analysis in order to select a proper PSD shape. It also assumes a certain constraint on the large particles content.

Content and size of the large particles calculated from attenuation spectra are in good agreement with a priori known amount and size of the added large particles, which shows consistency of the bimodal PSD calculated from the attenuation spectra.



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